

High-Quality Cu–Al Nanocrystals for Enhanced CO₂ Electroreduction

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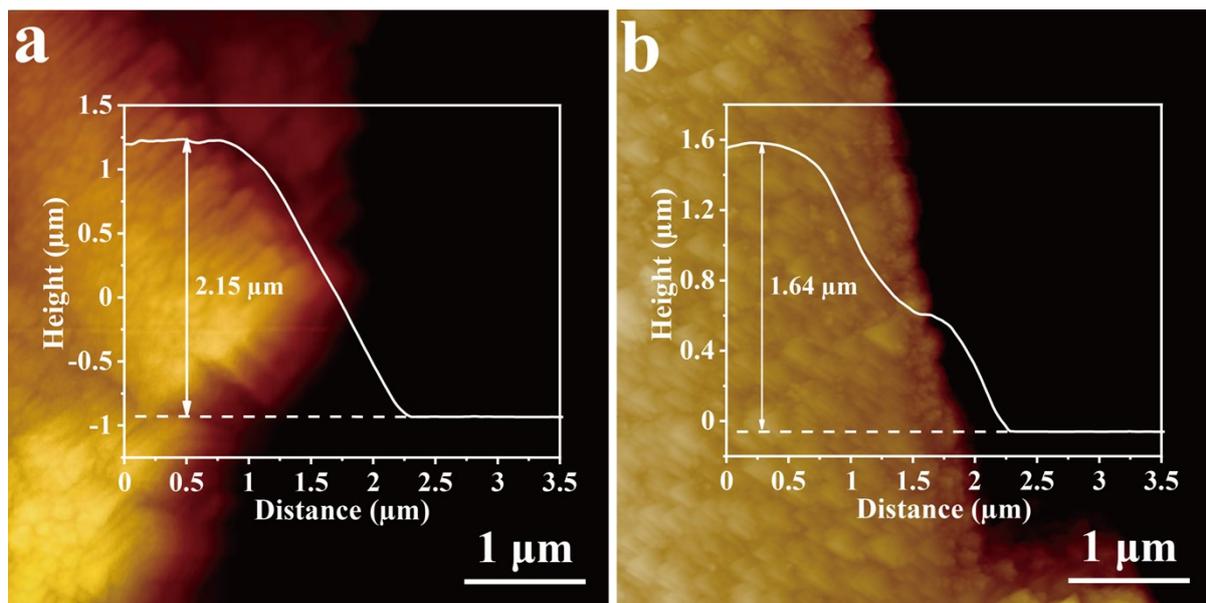


Figure S1. AFM images of (a) Cu and (b) Al thin films on Si wafer prepared by magnetron sputtering with the same deposition conditions as on carbon papers. The insets are the corresponding height profiles.

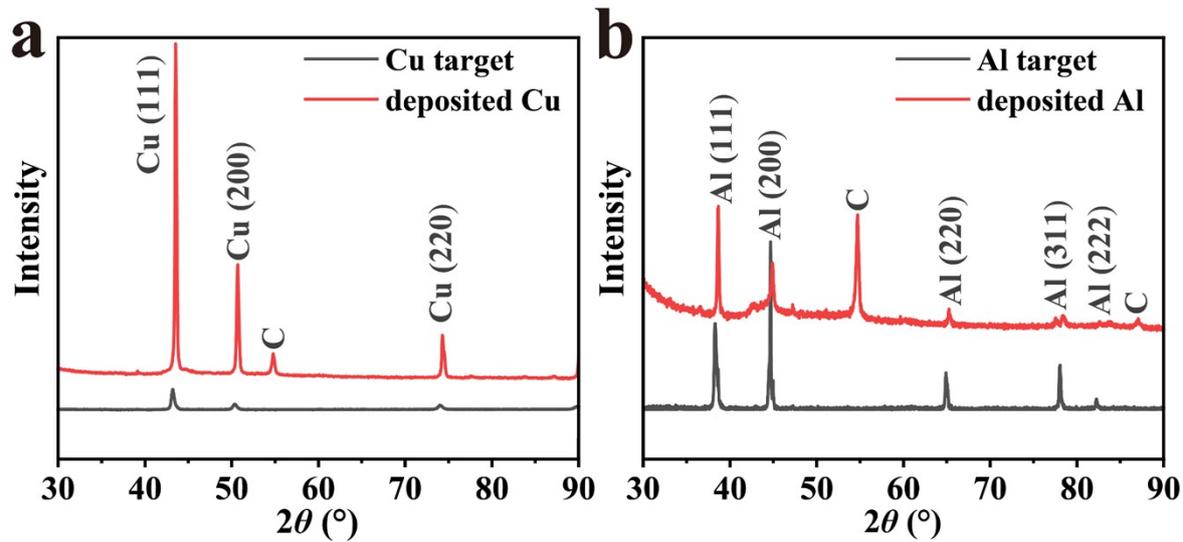


Figure S2. XRD patterns of (a) Cu and (b) Al targets and the deposited corresponding metals on carbon papers by magnetron sputtering.

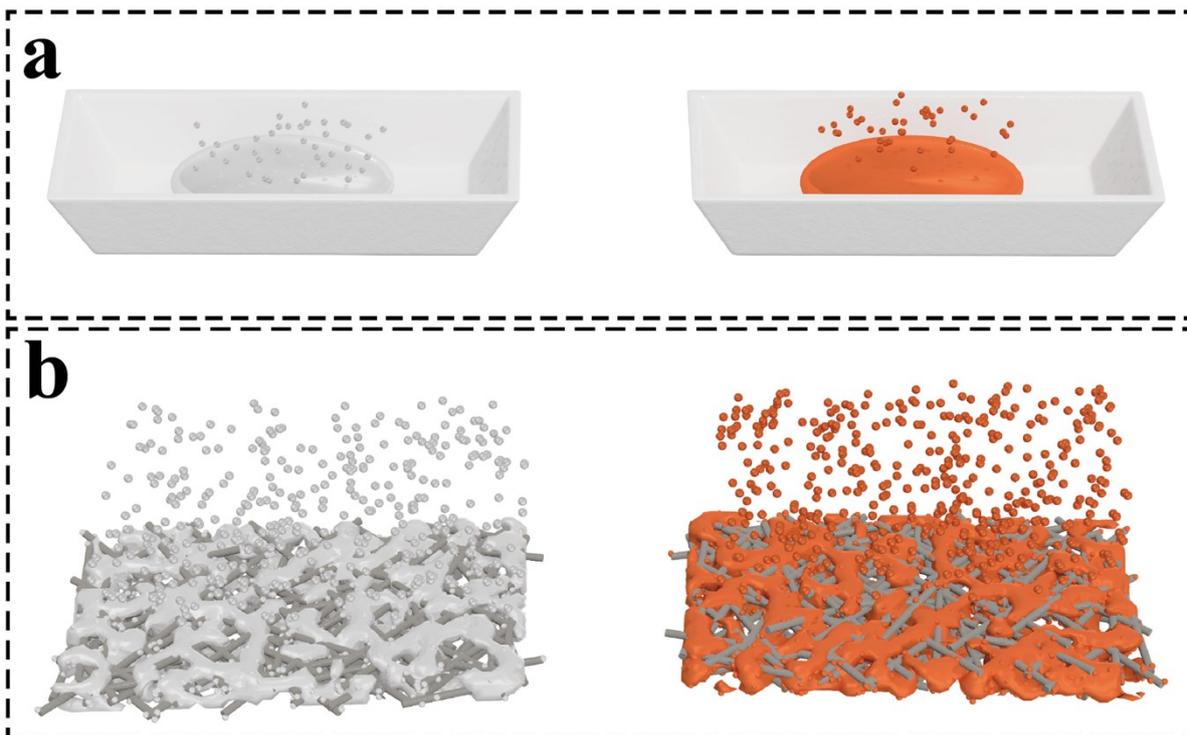


Figure S3. Schematic illustration for thermally excited atoms from (a) Cu and Al droplets formed via powder precursors and (b) Cu- and Al-covered carbon papers, respectively. Gray and brown represent Al and Cu, respectively.

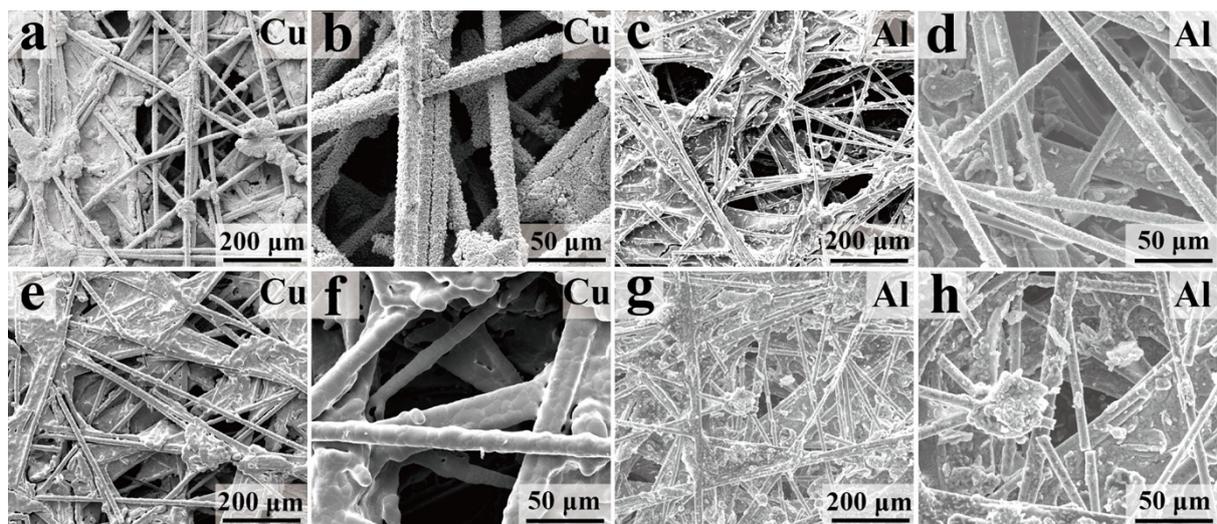


Figure S4. SEM images with different magnifications of the deposited Cu and Al on carbon papers (a–d) before and (e–f) after the CVD process.

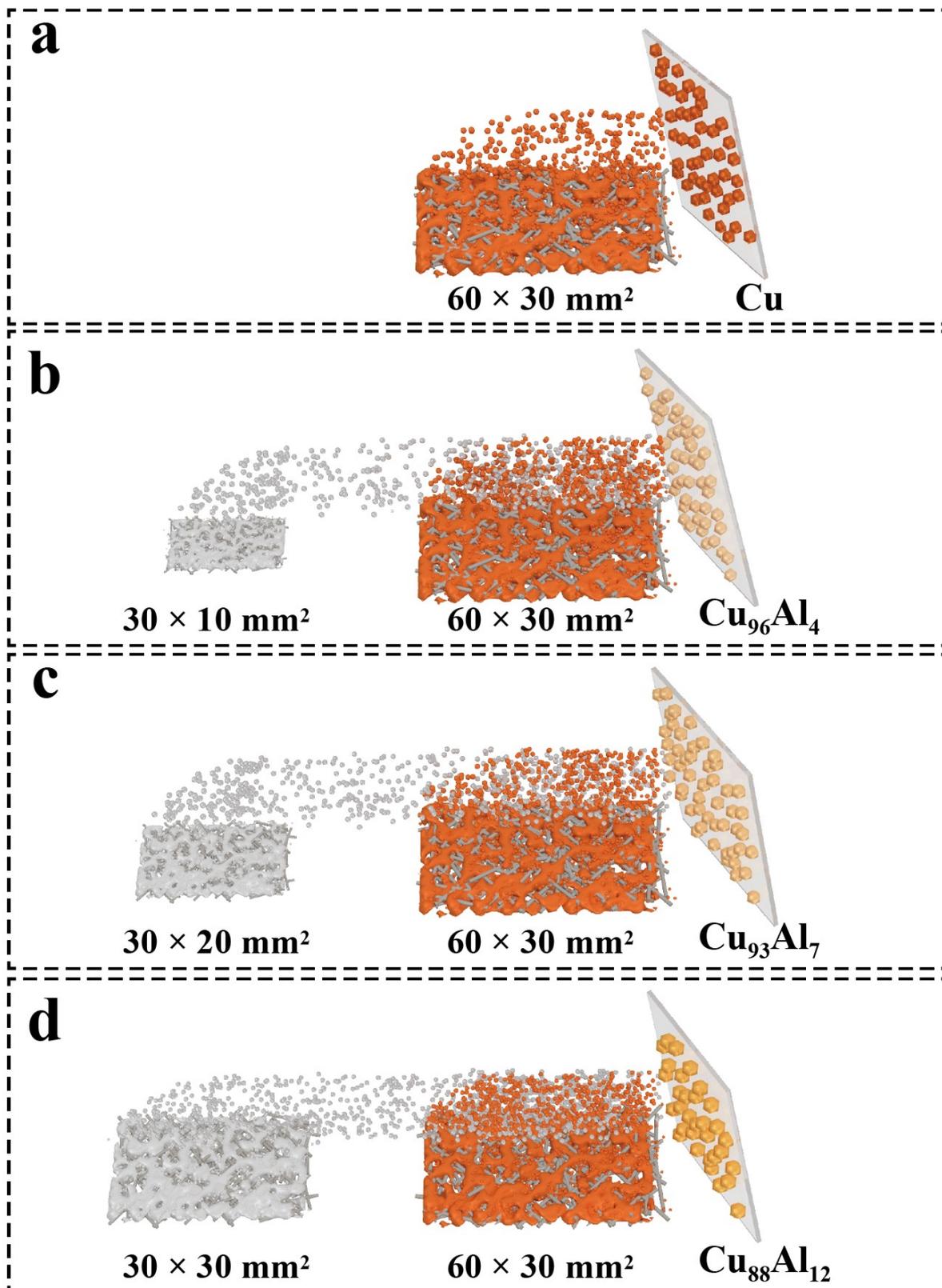


Figure S5. Schematic illustration for preparing (a) Cu, (b) $\text{Cu}_{96}\text{Al}_4$, (c) $\text{Cu}_{93}\text{Al}_7$, and (d) $\text{Cu}_{88}\text{Al}_{12}$ nanocrystals using Cu- and Al-deposited carbon paper with different sizes. Gray and brown represent Al and Cu, respectively.

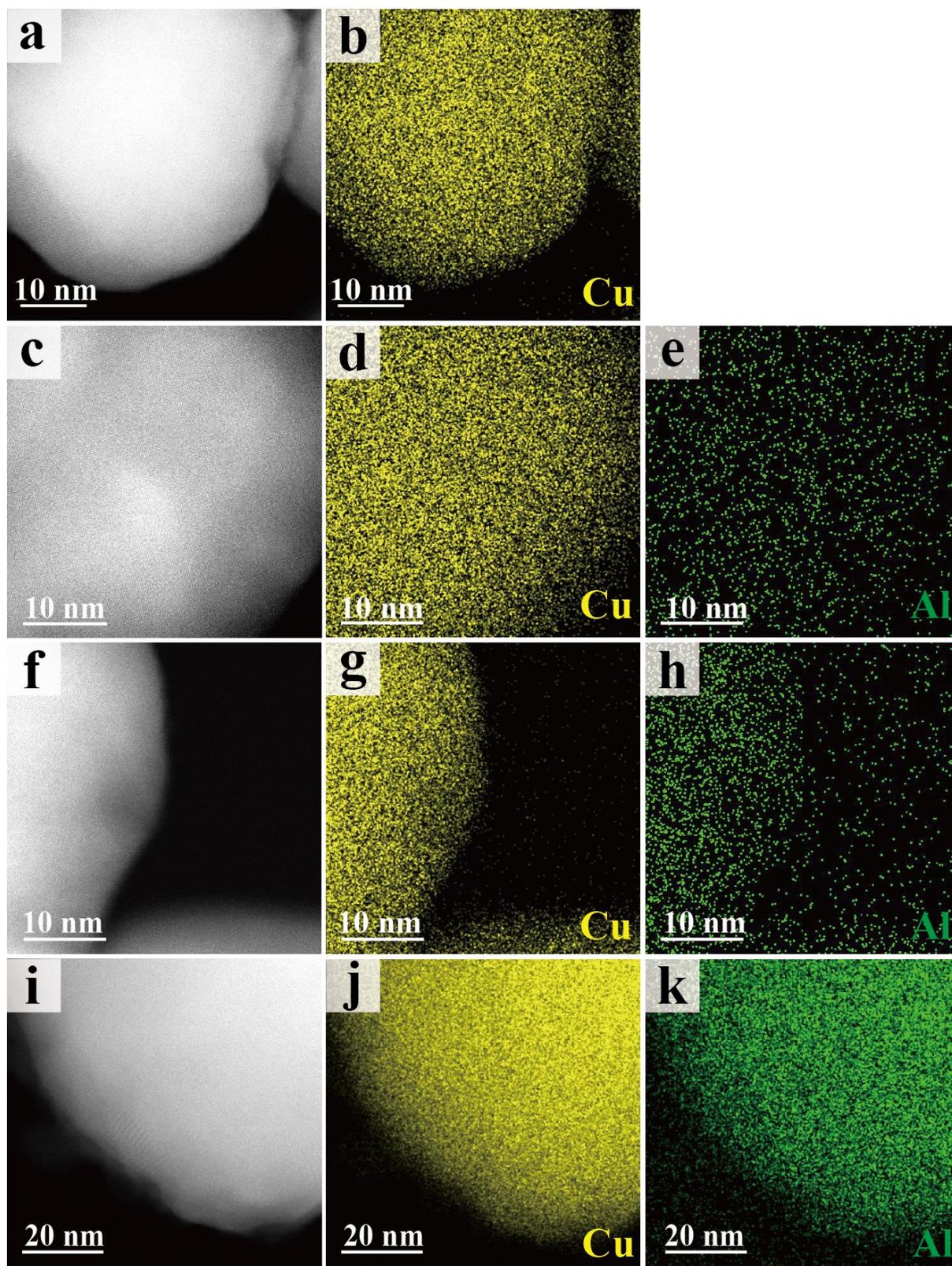


Figure S6. HAADF-STEM images and the corresponding EDS mappings of (a, b) Cu, (c–e) $\text{Cu}_{96}\text{Al}_4$, (f–h) $\text{Cu}_{93}\text{Al}_7$, and (i–k) $\text{Cu}_{88}\text{Al}_{12}$ single crystals.

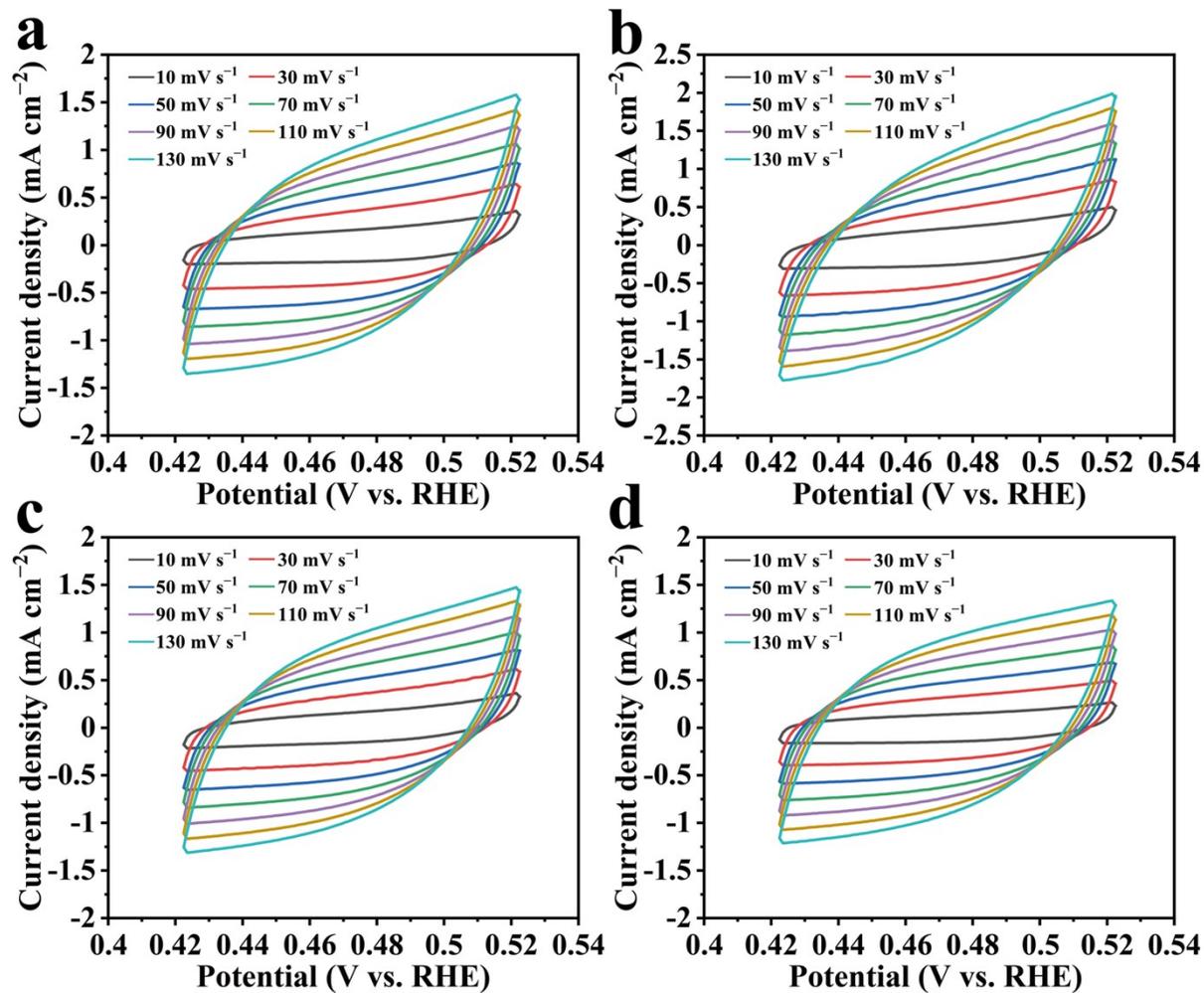


Figure S7. CV curves of (a) Cu, (b) Cu₉₆Al₄, (c) Cu₉₃Al₇, and (d) Cu₈₈Al₁₂ nanocrystals tested in the region from 0.42 to 0.52 V vs. RHE at scan rates from 10 to 130 mV s⁻¹.

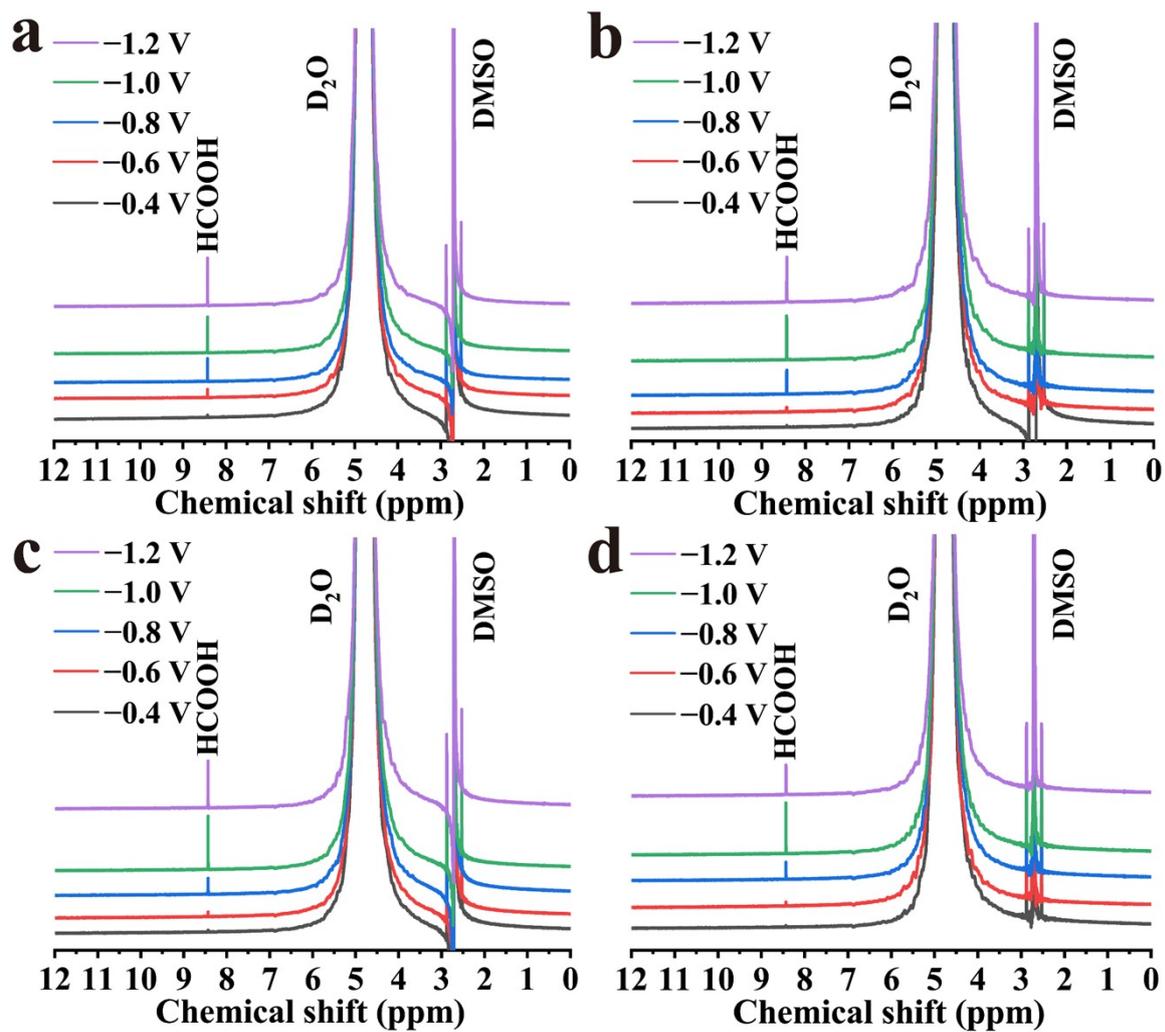


Figure S8. ^1H NMR spectra of the CO_2RR liquid products of (a) Cu, (b) $\text{Cu}_{96}\text{Al}_4$, (c) $\text{Cu}_{93}\text{Al}_7$, and (d) $\text{Cu}_{88}\text{Al}_{12}$ nanocrystals. The liquid samples were obtained after the catalytic reaction for 2 h at voltages of -0.4, -0.6, -0.8, -1, and -1.2 V vs. RHE, respectively.

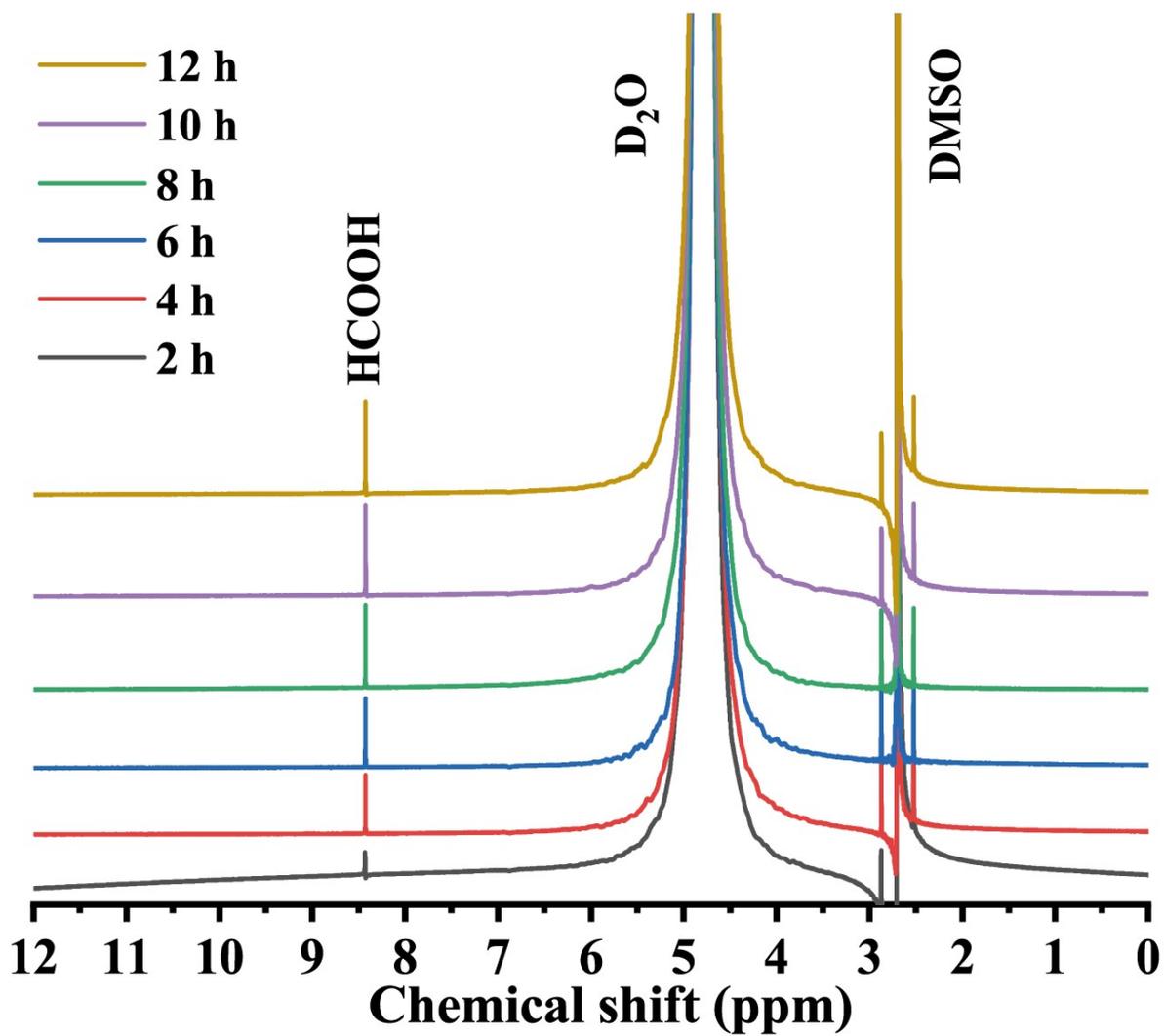


Figure S9. ^1H NMR spectra of the CO_2RR liquid products of $\text{Cu}_{96}\text{Al}_4$ nanocrystal tested at -0.8 V vs. RHE for 12 h. The liquid sample was obtained at 2 h intervals.

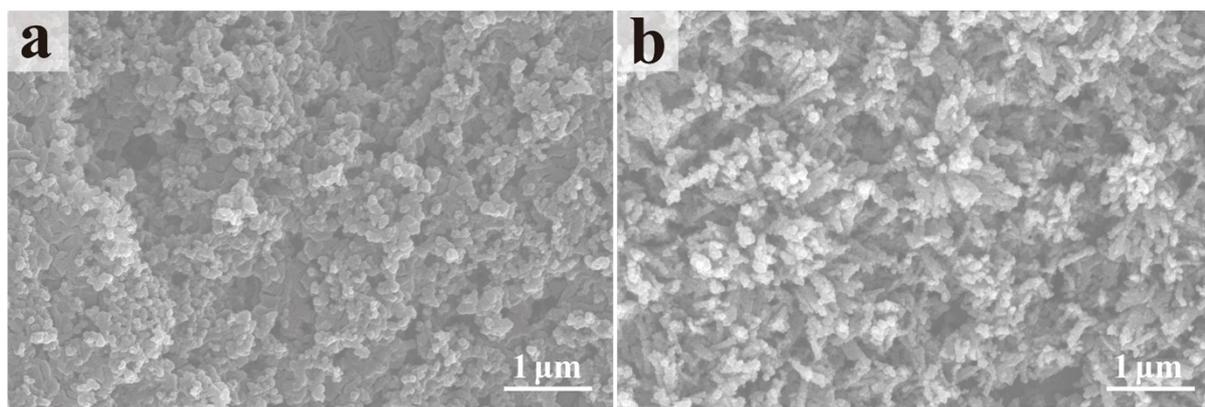


Figure S10. SEM images of Cu_9Al_4 nanocrystal (a) before and (b) after 12 hours of CO_2RR at -0.8 V vs. RHE.

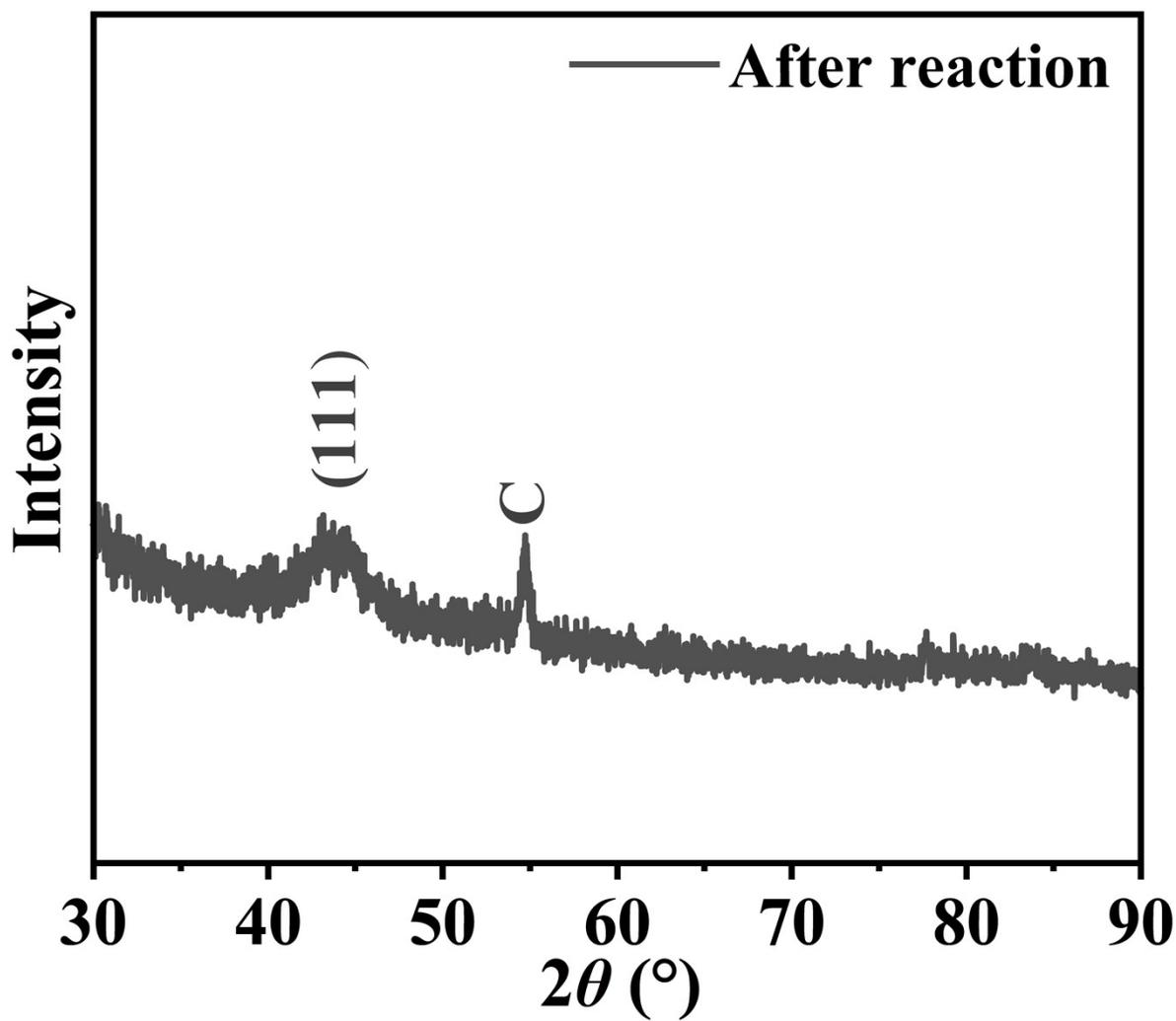


Figure S11. XRD pattern of Cu_9Al_4 nanocrystal after 12 h of CO_2 RR at -0.8 V vs. RHE.

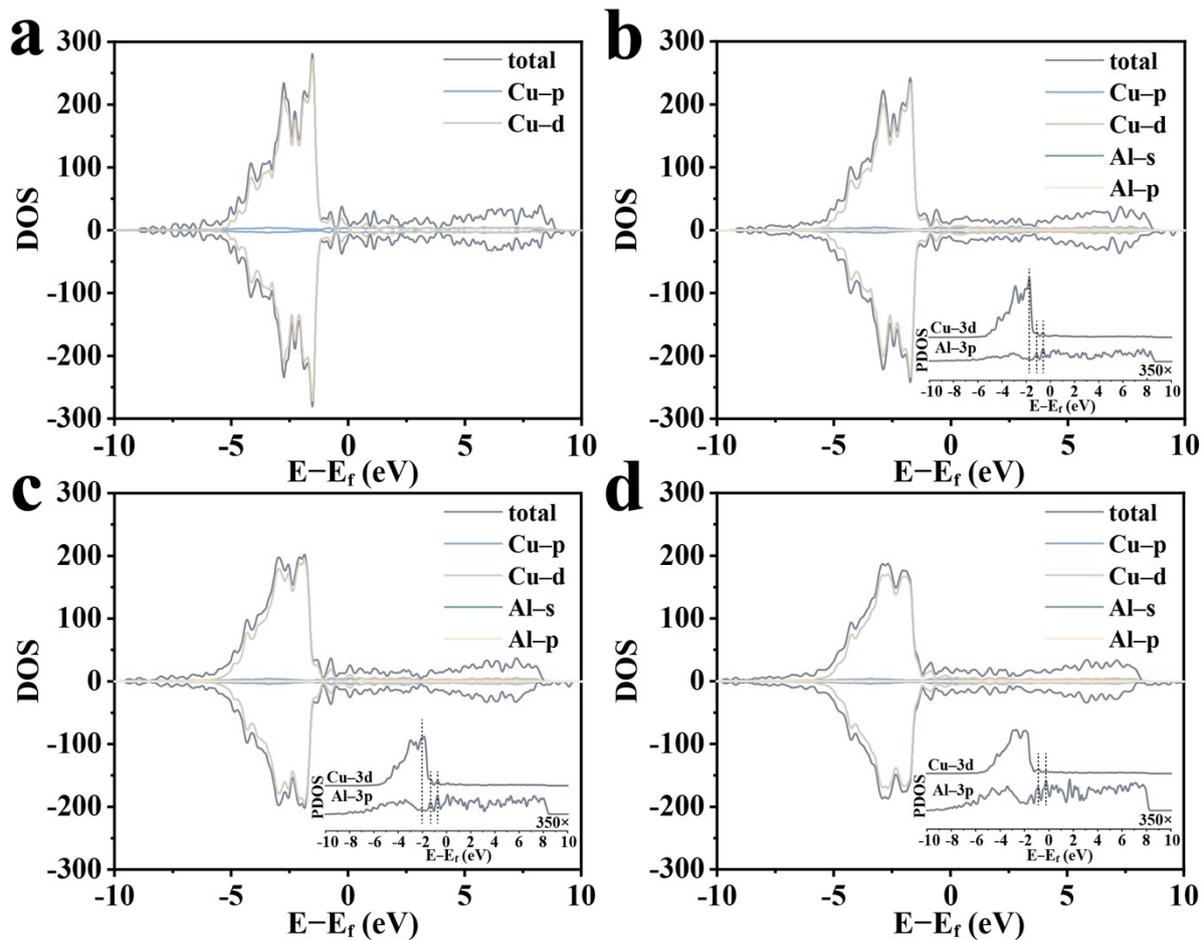


Figure S12. The total density of states (DOS) of (a) Cu, (b) $\text{Cu}_{96}\text{Al}_4$, (c) $\text{Cu}_{93}\text{Al}_7$, and (d) $\text{Cu}_{88}\text{Al}_{12}$ nanocrystals. The insets are projected DOS (PDOS) of Cu-3d and Al-3p orbitals magnified 350 \times .

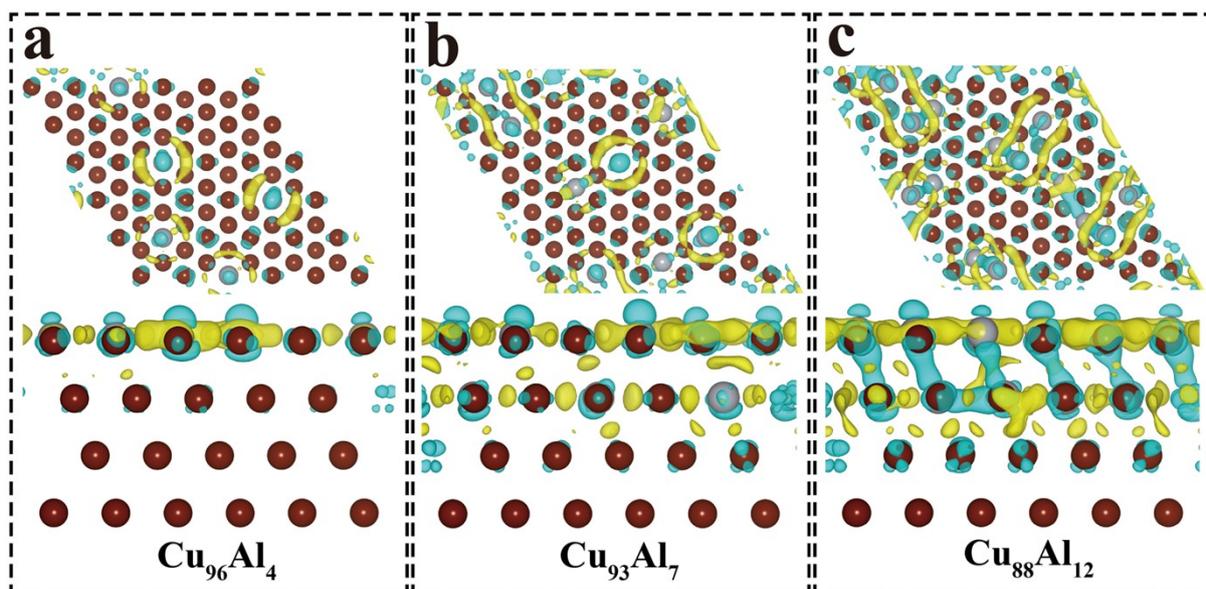


Figure S13. Schematic illustration of the Bader charge of (a) $\text{Cu}_{96}\text{Al}_4$, (b) $\text{Cu}_{93}\text{Al}_7$, and (c) $\text{Cu}_{88}\text{Al}_{12}$ nanocrystals. The above is a top view, and the below is a side view. Yellow and cyan regions represent electron accumulation and depletion, separately.

Table S1. The elemental analyses of Cu, Cu₉₆Al₄, Cu₉₃Al₇, and Cu₈₈Al₁₂ single crystals using HAADF-STEM EDS.

Samples	Cu (at%)	Al (at%)
Cu	97.78	
Cu ₉₆ Al ₄	96.27	3.73
Cu ₉₃ Al ₇	92.79	7.21
Cu ₈₈ Al ₁₂	87.66	12.34

Table S2. The values of the equivalent circuit element in the EIS diagrams of Cu, Cu₉₆Al₄, Cu₉₃Al₇, and Cu₈₈Al₁₂ nanocrystals. The R_s , R_{ct} , and R_{total} represent the solution resistance, charge transfer resistance, and the total resistance, respectively.

Samples	R_s (Ω)	R_{ct} (Ω)	R_{total} (Ω)
Cu	7.77	3.12	10.89
Cu ₉₆ Al ₄	7.4	1.34	8.74
Cu ₉₃ Al ₇	8.23	3.98	12.21
Cu ₈₈ Al ₁₂	8.76	5.91	14.67

Table S3. The comparison of FE for Cu-based alloy catalysts in H-type cells.

Catalysts	Electrolytes	Potential (vs. RHE)	Products	FE (%)	Refs.
Cu₉₆Al₄				77.71, 18.01	
Cu	0.5 M KHCO ₃	-0.8 V	HCOOH, CO	76.43, 13.32	This work
Cu ₉₃ Al ₇				72.24, 12.91	
Cu ₈₈ Al ₁₂				67.51, 7.66	
Cu-SnO ₂	0.5 M KHCO ₃	-0.9 V	HCOOH	92	1
O _p -Ag ₁ In	0.5 M NaHCO ₃	-0.95 V	HCOOH	92.03	2
Ga _{83.2} In _{16.8}	0.1 M KHCO ₃	-1.9 V	HCOOH	98	3
Sb ₂₅ Bi ₇₅	0.5 M KHCO ₃	-1.0 V	HCOOH	~85	4
CuPd-1.5-alloy	0.5 M KHCO ₃	-0.7 V	CH ₃ COOH, C ₁₊	46.5±2.1, ~37	5
PdCu ₃ /NC	0.1 M KHCO ₃	-0.5 V	CO	99.8	6
Cu ₅ Ga ₁	0.1 M KHCO ₃	-1.0 V	C ₁₊ , C ₂₊	~85	7
Cu-Zn	0.1 M KHCO ₃	-1.0 V	EtOH, C ₂₊	19, 56	8
Tb _{2.9} PAT	0.5 M KHCO ₃	-0.8 V	CO	95.7	9
V-CuInSe ₂	0.5 M KHCO ₃	-0.7 V	CO	91	10
Ag ₆₅ -Cu ₃₅ JNS 100	0.1 M KHCO ₃	-1.4 V	C ₁₊ , C ₂₊	15, 72.1	11
BiCu-SAA	0.1 M KHCO ₃	-1.1 V	C ₁₊ , C ₂₊	~14, 73.4	12
CuGa ₁₇	0.1 M KHCO ₃	-1.2 V	C ₁₊ , C ₂₊	~75	13
Bi ₈₅ Pb ₁₅	0.2 M KHCO ₃	-1.0 V	HCOOH	96.5	14
CuSn NPs/C-H	0.1 M KHCO ₃	-1.0 V	CO, HCOOH	~90	15
Cu _{0.07} Zn	0.1 M KHCO ₃	-1.15 V	CO	77.3	16
Pd@Pd ₃ Au ₇	0.1 M KHCO ₃	-0.5 V	CO	94	17
CuSn-4	0.5 M KHCO ₃	-1.4 V	HCOOH	87.7	18
Pd ₄ Ag	0.1 M KHCO ₃	-0.23 V	HCOOH	94	19
BiPdC	0.1 M KHCO ₃	-0.97 V	HCOOH	63.41	20
AuCu/Cu-SCA	0.5 M KHCO ₃	-1.0 V	C ₁₊ , C ₂₊	~78	21
Cu-Pd	0.1 M KHCO ₃	-0.9 V	CO	87	22
Cu ₃ -Ag ₃ Au	0.1 M KHCO ₃	-1.2 V	C ₂ H ₄ , C ₁₊	69±5, ~20	23
CuIn-1 mM	0.1 M KHCO ₃	-1.0 V	CO	86	24
s-PdNi/CNFs-1000	0.1 M KHCO ₃	-0.88 V	CO	96.6	25
Cu-Ag	0.1 M KHCO ₃	-1.0 V	C ₁₊ , C ₂₊	~90	26
AuAg-R	0.1 M KHCO ₃	-0.87V	CO	>80	27
Cu-In ₂ O ₃ /C	0.1 M KHCO ₃	-0.7 V	CO	95	28
Ag@Cu ₂ O	0.1 M KHCO ₃	-1.6 V	C ₁₊ , C ₂₊	~10, 78.5	29
Cu ₇₀ Zn ₃₀ NPs	0.1 M KHCO ₃	-1.35 V	C ₁₊ , C ₂₊	~80.2	30
S-CuSn	0.5 M KHCO ₃	-1.2 V	HCOOH	91.5	31
PdIn@In ₂ O ₃	0.5 M KHCO ₃	-0.9 V	CO	75.36	32
4H/fcc Au@Cu	0.1 M KHCO ₃	-0.82 V	C ₁₊ , C ₂₊	~91	33
Au ₅₀ Ag ₅₀	0.1 M KHCO ₃	-0.7 V	CO	97.8	34
Cu ₁ Fe ₂ /NC	0.5 M KHCO ₃	-0.7 V	CO	98.91	35

Table S4. FE of the CO₂RR for Cu₉₆Al₄ nanocrystal tested at -0.8 V vs. RHE for 12 h. The gas and liquid products were recorded at 2 h intervals.

Time (h)	FE_{HCOOH} (%)	FE_{CO} (%)	FE_{H₂} (%)	FE_{C₁} (%)
2	77.61	16.91	4.88	94.52
4	78.38	15.92	4.74	94.3
6	75.98	16.66	6.25	92.64
8	74.4	16.47	6.16	90.87
10	70.43	16.73	7.88	87.16
12	46.04	9.35	42.85	55.39

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